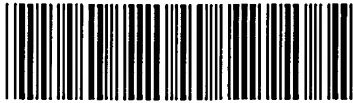


**Search Notes**

Application/Control No.

10/735,783

Examiner

Winnie Yip

Applicant(s)/Patent under  
Reexamination

CHEN, HSIA-HUI

Art Unit

3636

**SEARCHED**

Class	Subclass	Date	Examiner
Update	Searched all previous Cls/Subs	4/7/2006	WSY

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR